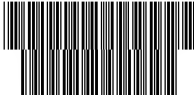


<b>Search Notes</b>  	<b>Application/Control No.</b>  0955397012423894	<b>Applicant(s)/Patent Under Reexamination</b>  ALLAVARPU ET AL.ZHANG ET AL.
	<b>Examiner</b>  John ChavisJohn Chavis	<b>Art Unit</b>  21932193

SEARCHED			
Class	Subclass	Date	Examiner
717717	149124	11/17/093/30/10	/JC//JC/

SEARCH NOTES			
Search Notes	Date	Examiner	
West (IBM TDB, Derwent, EPO, JPO, USPAT, PGPUBS) anded with word searchWest Update anded with word search	11/17/093/30/10	/JC//JC/	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
717717	149124	11/17/093/31/10	/JC//JC/

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